

Search Notes

Application/Control No.

09/922,945

Examiner

Minh Dieu Nguyen

Applicant(s)/Patent under
Reexamination

FUKASAWA, MIKIO

Art Unit

2137

SEARCHED

Class	Subclass	Date	Examiner
726	22-23, 25	5/2/2006	MDN
718	102, 103	5/2/2006	MDN
709	224	5/2/2006	MDN
705	51-52	5/2/2006	MDN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
726	22	5/2/2006	MDN
709	224	5/2/2006	MDN
705	51	5/2/2006	MDN

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated inventor name search on EAST (US-PAT; US-PG-PUB; EPO; JPO; DERWENT; IBM-TDB)	5/2/2006	MDN
Updated text and class search on EAST (US-PAT; US-PG-PUB; EPO; JPO; DERWENT; IBM-TDB)	5/2/2006	MDN
Consulted with G. Barron on allowability issue	5/2/2006	MDN